

**Search Notes**

Application/Control No.

10/736,579

Examiner

Hal I. Kaplan

Applicant(s)/Patent under  
Reexamination

SCHROER ET AL.

Art Unit

2836

**SEARCHED**

Class	Subclass	Date	Examiner
174	52.6	2/1/2006	HK
361	752	2/1/2006	HK
361	797	2/1/2006	HK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Interference Search History Printout		2/1/2006	HK

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
307/134;174/52.1;181/167;336/192; 338/199;422/99,102,104;439/557 (consulted Robert DeBeradinis)	2/1/2006	HK
174/52.1-52.6 (consulted Dhiru Patel)	2/1/2006	HK
361/752,797,800 (consulted Hung Bui)	2/1/2006	HK
439/76.1 (consulted Tho Ta)	2/1/2006	HK
EAST (US-PGPUB,USPAT,USOCR, EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	1/31/2006	HK
EAST (US-PGPUB,USPAT,USOCR, EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	2/1/2006	HK